Search Notes			

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/644,478	HIBARI, EIKO	
Examiner	Art Unit	
Mark J. Beauchaine	3653	

SEARCHED				
Class	Subclass	Date	Examiner	
194	302,293, 303,317, 320,325, 328,	7/5/2005	МЈВ	
	344			
453	18,56			
382	136			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Abare	classes	subclas	75	
have	been se	arch upo	taled	
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2/6/06	using T	DE USPGF	US_	
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SHEEC		2/6/06	20	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST 2.0.1.4 - USPAT, USPGPUB, JPO, EPO, DEREWNT	7/5/2005	MJB	
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